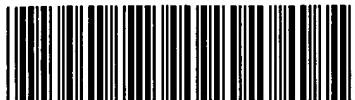


Search Notes**Application/Control No.**

10/719,536

Examiner

Ryan Dare

Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

2186

SEARCHED

Class	Subclass	Date	Examiner
711	169	2/3/2006	RD
711	171	2/3/2006	RD
711	172	2/3/2006	RD
711	161	2/3/2006	RD
711	162	2/3/2006	RD
710	30	2/3/2006	RD
710	33	2/3/2006	RD
710	34	2/3/2006	RD
710	35	2/3/2006	RD
710	38	2/3/2006	RD
710	57	2/3/2006	RD
710	29	2/3/2006	RD
709	230	2/3/2006	RD
709	236	2/3/2006	RD

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST(US-PGPUB; USPAT, USOCR; EPO; JPO; DERWENT; IBM_TDB)	2/3/2006	RD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
711	169	2/3/2006	RD
711	171	2/3/2006	RD
711	172	2/3/2006	RD

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